

Hutchip  
 桥芯科技

**HCNR3936E**

**30V N-Channel MOSFET**

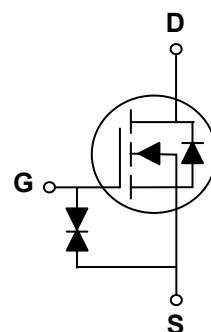
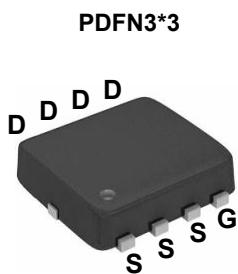
### General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

### Features

$V_{DS}$	30V
$I_D$ (at $V_{GS}=10V$ )	40A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	4.7mΩ(Typ)
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	5.8mΩ(Typ))

ESD protected up to 2KV



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$ (TC=25°C)	40	A
	$I_D$ (TC=100°C)	27	A
Drain Current – Pulsed	$I_{DM}$	160	A
Maximum Power Dissipation	$P_D$	45	W
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance junction-case	$R_{\theta JC}$		2.8	°C /W
Thermal Resistance junction-to-Ambient	$R_{\theta JA}$		62	°C /W

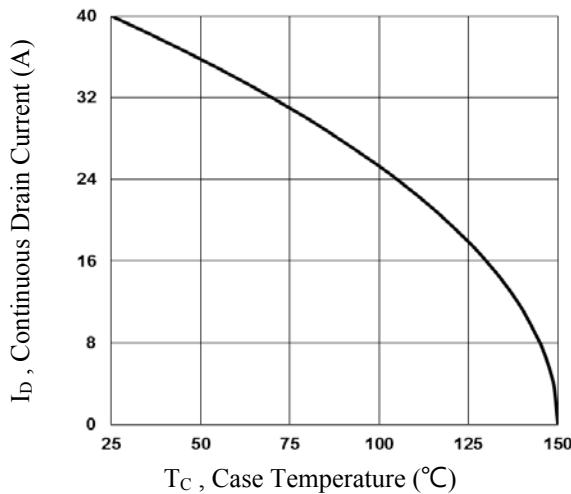
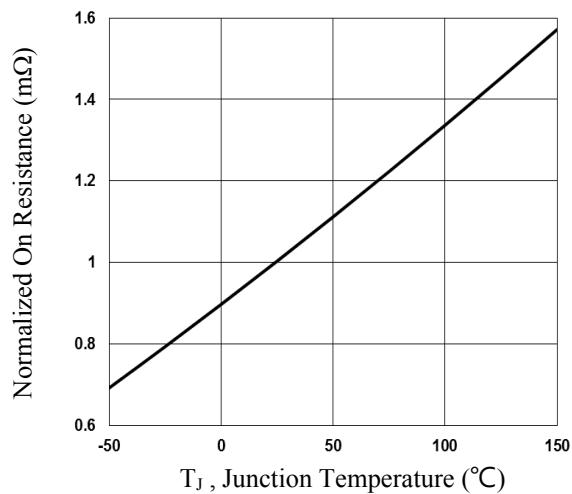
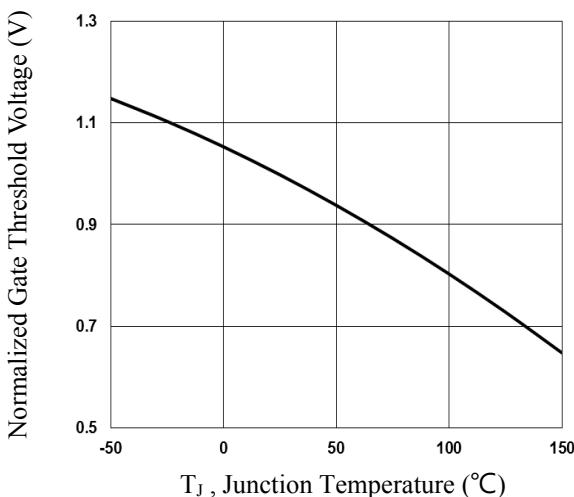
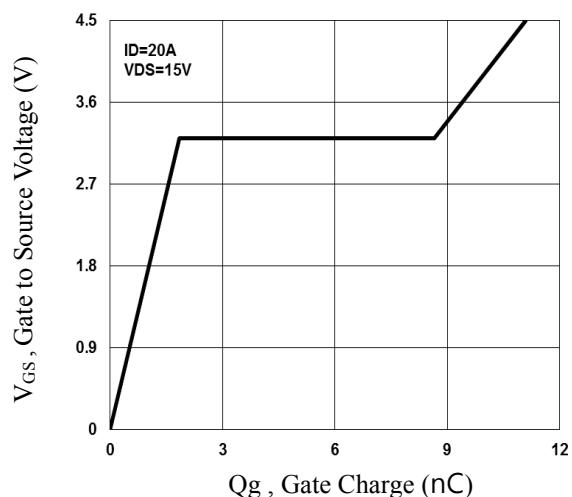
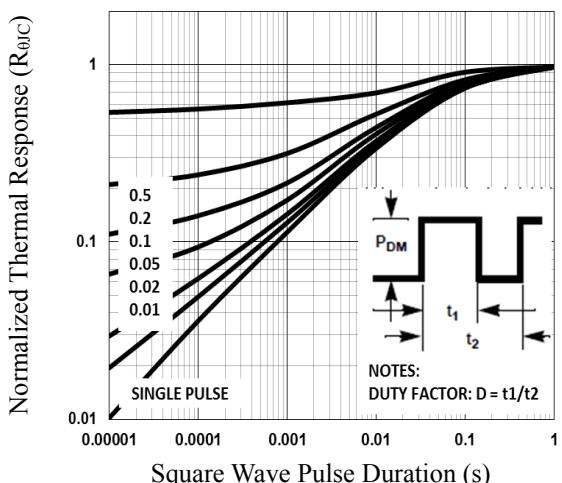
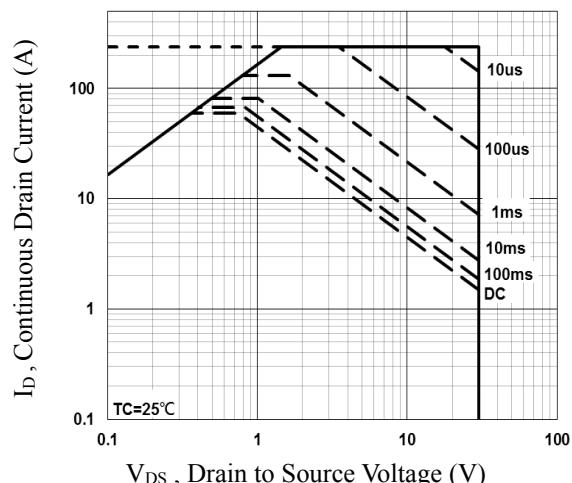
## Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V$			1	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.5	2.5	V
$R_{DS(ON)}$	Drain-Source On-State Resistance	$V_{GS}=10V, I_D=20A$		4.8	6.0	$m\Omega$
		$V_{GS}=4.5V, I_D=10A$		5.7	8.0	$m\Omega$
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, F=1.0MHz$		1210		pF
$C_{oss}$	Output Capacitance			190		pF
$C_{rss}$	Reverse Transfer Capacitance			100		pF
<b>SWITCHING PARAMETERS</b>						
$t_{d(on)}$	Turn-on Delay Time	$V_{GS}=10V$ $V_{DS}=15V$ $R_L=0.75\Omega$ $R_{GEN}=3\Omega$		7.3		nS
$t_r$	Turn-on Rise Time			14.5		nS
$t_{d(off)}$	Turn-Off Delay Time			35.8		nS
$t_f$	Turn-Off Fall Time			9.6		nS
$Q_g$	Total Gate Charge	$V_{DS}=15V, I_D=4.5A$ $V_{GS}=4.5V$		11		nC
$Q_{gs}$	Gate-Source Charge			1.85		nC
$Q_{gd}$	Gate-Drain Charge			6.8		nC
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=1A$		0.72	1.3	V
$R_g$	Gate resistance	$V_{GS}=0V, V_{DS}=0V, F=1MHz$		2.5		$\Omega$

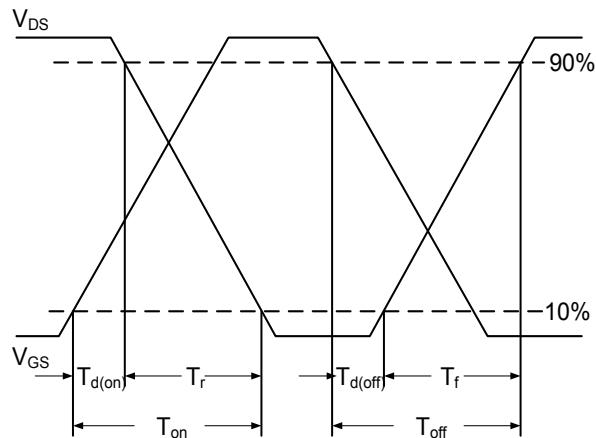
Note:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .
3. Essentially independent of operating temperature.

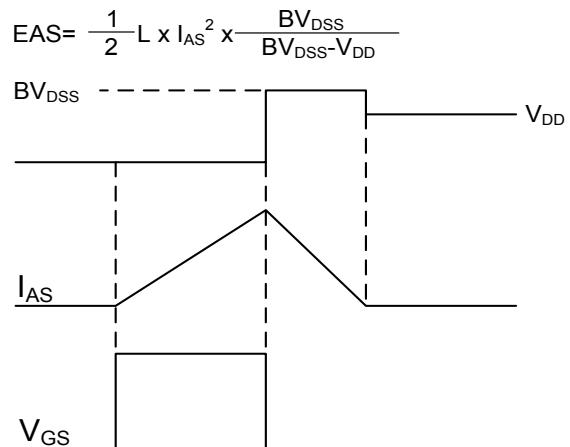
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

**Fig.1 Continuous Drain Current vs.  $T_C$** **Fig.2 Normalized RDS(on) vs.  $T_J$** **Fig.3 Normalized  $V_{th}$  vs.  $T_J$** **Fig.4 Gate Charge Waveform****Fig.5 Normalized Transient Impedance****Fig.6 Maximum Safe Operation Area**

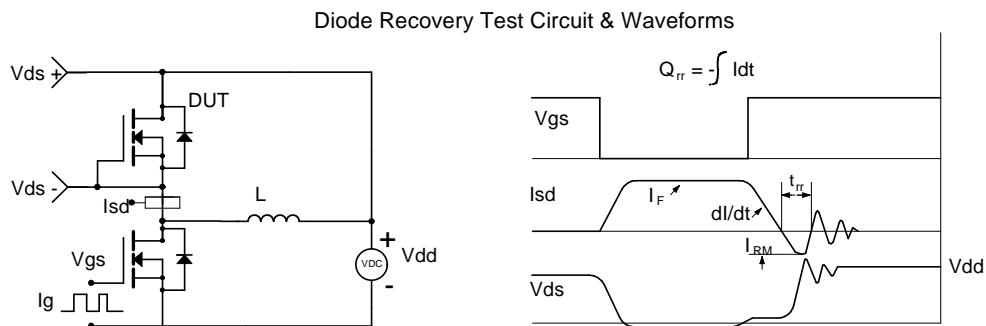
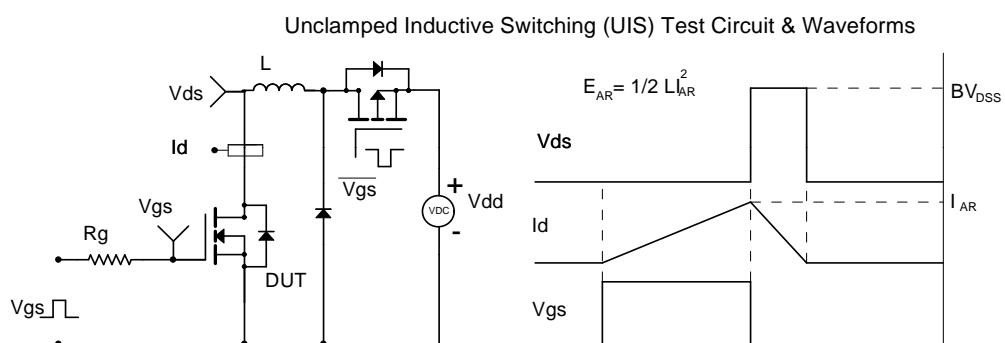
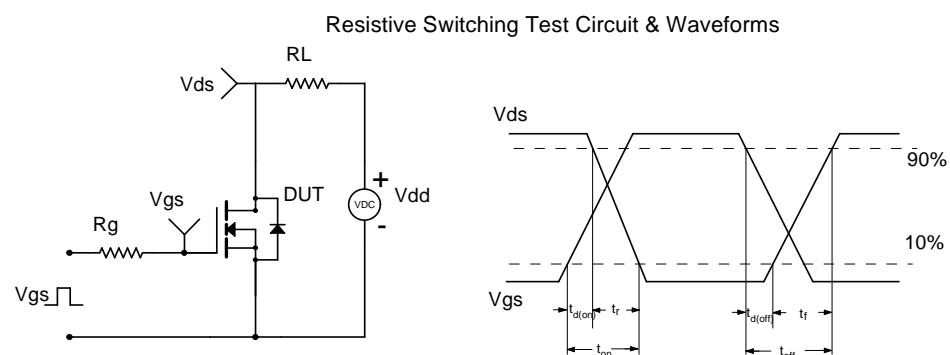
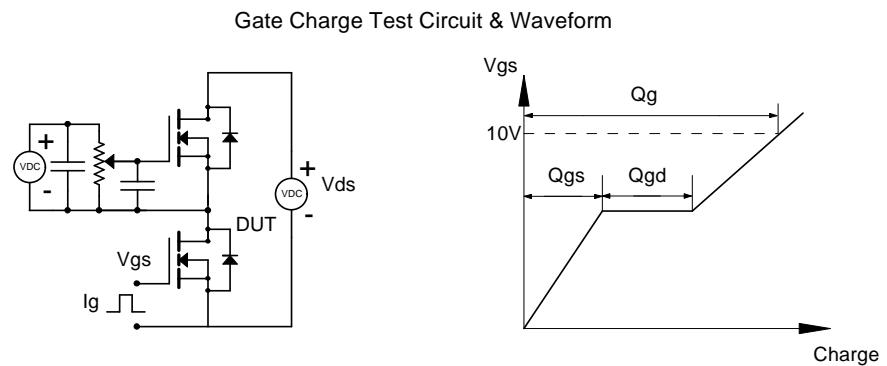
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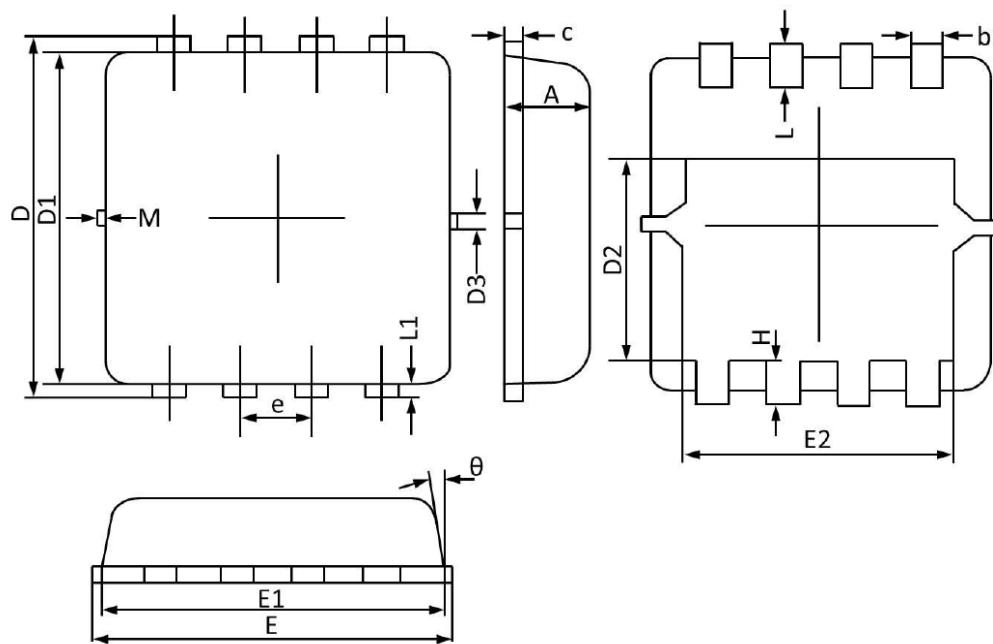
**Fig.7** Switching Time Waveform



**Fig.8** EAS Waveform



## PDFN3x3 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	0.800	0.700	0.031	0.028
b	0.350	0.250	0.013	0.010
c	0.250	0.100	0.009	0.004
D	3.450	3.250	0.135	0.128
D1	3.200	3.000	0.125	0.119
D2	1.980	1.780	0.077	0.070
D3	0.130(REF)		0.005(REF)	
E	3.400	3.200	0.133	0.126
E1	3.200	3.000	0.125	0.119
E2	2.590	2.390	0.102	0.094
e	0.650(BSC)		0.026(BSC)	
H	0.500	0.300	0.019	0.011
L	0.500	0.300	0.019	0.011
L1	0.130(REF)		0.005(REF)	
θ	12°	0°	12°	0°
M	0.150(REF)		0.006(REF)	